Notice of References Cited Application/Control No. 10/589,431 Examiner Vivian Chen Applicant(s)/Patent Under Reexamination SHINODA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0183473	12-2002	Matyjaszewski et al.	526/335
*	В	US-7,354,973	04-2008	Flexman, Edmund Arthur	525/162
*	С	US-7,049,373	05-2006	Matyjaszewski et al.	525/242
*	D	US-5,683,723	11-1997	Spenlehauer et al.	424/501
*	Е	US-6,869,985	03-2005	Mohanty et al.	523/124
*	F	US-5,216,050	06-1993	Sinclair, Richard G.	524/108
*	G	US-7,160,948	01-2007	Matsuo et al.	525/92R
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	WO 00/52094	09-2000	wo	Pham	
	0	WO 02/06384	01-2002	wo	Ede et al	
	Ρ	WO 02/068485	09-2002	wo	Matyjaszewski et al	
	Ø	WO 03/082980	10-2003	wo	Obuchi et al	
	R	WO 01/53369	07-2001	wo	Ota et al	
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.